



ALPHA & OMEGA
SEMICONDUCTOR



AO6602

Complementary Enhancement Mode Field Effect Transistor

General Description

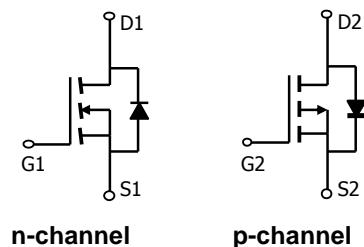
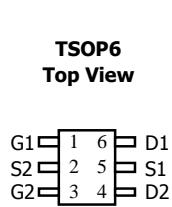
The AO6602 uses advanced trench technology to provide excellent $R_{DS(ON)}$ and low gate charge. The complementary MOSFETs form a high-speed power inverter, suitable for a multitude of applications.

Standard Product AO6602 is Pb-free (meets ROHS & Sony 259 specifications). AO6602L is a Green Product ordering option. AO6602 and AO6602L are electrically identical.

Features

| | |
|--------------------------------|--------------------------|
| n-channel | p-channel |
| V_{DS} (V) = 30V | -30V |
| I_D = 3.1A (V_{GS} = 10V) | -2.7A (V_{GS} = -10V) |

$R_{DS(ON)}$
 $< 75m\Omega$ (V_{GS} = 10V) $< 100m\Omega$ (V_{GS} = -10V)
 $< 115m\Omega$ (V_{GS} = 4.5V) $< 180m\Omega$ (V_{GS} = -4.5V)



Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter | Symbol | Max n-channel | Max p-channel | Units |
|--|------------------|---------------|---------------|-------|
| Drain-Source Voltage | V_{DS} | 30 | -30 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | ± 20 | V |
| Continuous Drain Current ^A | $T_A=25^\circ C$ | 3.1 | -2.7 | A |
| Pulsed Drain Current ^B | | 2.4 | -2.1 | |
| Power Dissipation | I_D | 12 | -12 | |
| Power Dissipation | $T_A=25^\circ C$ | 1.15 | 1.15 | W |
| | | 0.73 | 0.73 | |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | -55 to 150 | °C |

Thermal Characteristics: n-channel and p-channel

| Parameter | Symbol | Typ | Max | Units |
|--|-----------------|-----|-----|-------|
| Maximum Junction-to-Ambient ^A | $R_{\theta JA}$ | 78 | 110 | °C/W |
| Maximum Junction-to-Ambient ^A | | 106 | 150 | °C/W |
| Maximum Junction-to-Lead ^C | $R_{\theta JL}$ | 64 | 80 | °C/W |

N-Channel Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|---|-----|------|-----|------------------|
| STATIC PARAMETERS | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $I_D=250\mu\text{A}, V_{GS}=0\text{V}$ | 30 | | | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS}=24\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$ | | 1 | 5 | μA |
| I_{GSS} | Gate-Body leakage current | $V_{DS}=0\text{V}, V_{GS}=\pm20\text{V}$ | | | 100 | nA |
| $V_{\text{GS(th)}}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}, I_D=250\mu\text{A}$ | 1.2 | 1.9 | 2.5 | V |
| $I_{\text{D(ON)}}$ | On state drain current | $V_{GS}=10\text{V}, V_{DS}=5\text{V}$ | 10 | | | A |
| $R_{\text{DS(ON)}}$ | Static Drain-Source On-Resistance | $V_{GS}=10\text{V}, I_D=3.1\text{A}$ $T_J=125^\circ\text{C}$ | | 54 | 75 | $\text{m}\Omega$ |
| | | $V_{GS}=4.5\text{V}, I_D=2\text{A}$ | | 78 | 88 | $\text{m}\Omega$ |
| g_{FS} | Forward Transconductance | $V_{DS}=5\text{V}, I_D=3.1\text{A}$ | | 4.5 | | S |
| V_{SD} | Diode Forward Voltage | $I_S=1\text{A}$ | | 0.79 | 1 | V |
| I_S | Maximum Body-Diode Continuous Current | | | | 2.5 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C_{iss} | Input Capacitance | $V_{GS}=0\text{V}, V_{DS}=15\text{V}, f=1\text{MHz}$ | | 200 | 240 | pF |
| C_{oss} | Output Capacitance | | | 40 | | pF |
| C_{rss} | Reverse Transfer Capacitance | | | 20 | | pF |
| R_g | Gate resistance | $V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$ | | 2.3 | 3 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| $Q_g(10\text{V})$ | Total Gate Charge | $V_{GS}=10\text{V}, V_{DS}=15\text{V}, I_D=3.1\text{A}$ | | 6.5 | 8.5 | nC |
| $Q_g(4.5\text{V})$ | Total Gate Charge | | | 3.1 | 4 | nC |
| Q_{gs} | Gate Source Charge | | | 1.2 | | nC |
| Q_{gd} | Gate Drain Charge | | | 1.6 | | nC |
| $t_{\text{D(on)}}$ | Turn-On DelayTime | $V_{GS}=10\text{V}, V_{DS}=15\text{V}, R_L=4.7\Omega, R_{\text{GEN}}=3\Omega$ | | 3.3 | | ns |
| t_r | Turn-On Rise Time | | | 2.5 | | ns |
| $t_{\text{D(off)}}$ | Turn-Off DelayTime | | | 13.2 | | ns |
| t_f | Turn-Off Fall Time | | | 1.7 | | ns |
| t_{rr} | Body Diode Reverse Recovery Time | $I_F=3.1\text{A}, dI/dt=100\text{A}/\mu\text{s}$ | | 9.4 | 12 | ns |
| Q_{rr} | Body Diode Reverse Recovery Charge | $I_F=3.1\text{A}, dI/dt=100\text{A}/\mu\text{s}$ | | 3.5 | | nC |

A: The value of $R_{\theta JA}$ is measured with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The value in any given application depends on the user's specific board design. The current rating is based on the $t \leq 10\text{s}$ thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C: The $R_{\theta JA}$ is the sum of the thermal impedance from junction to lead $R_{\theta JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using <300 μs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The SOA curve provides a single pulse rating.

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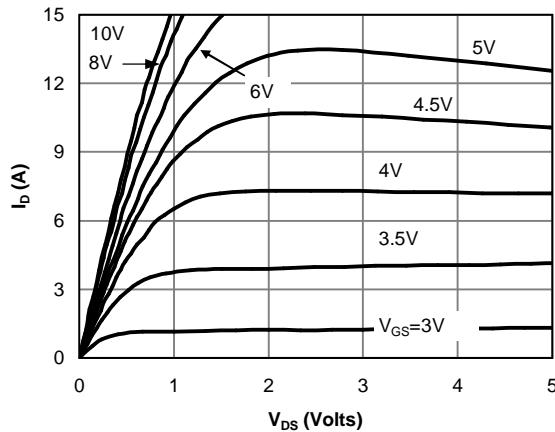
N-Channel Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Fig 1: On-Region Characteristics

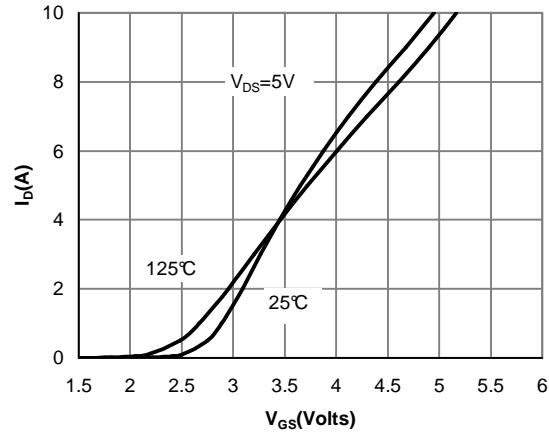


Figure 2: Transfer Characteristics

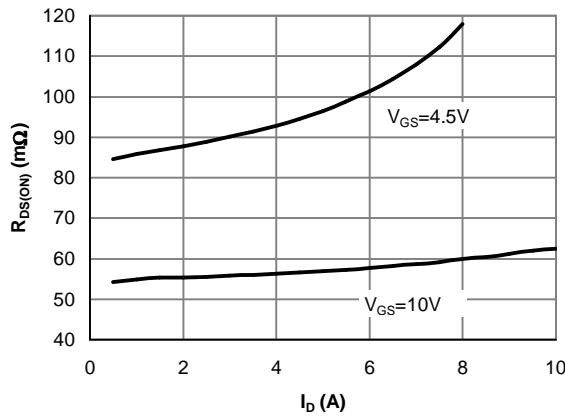


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

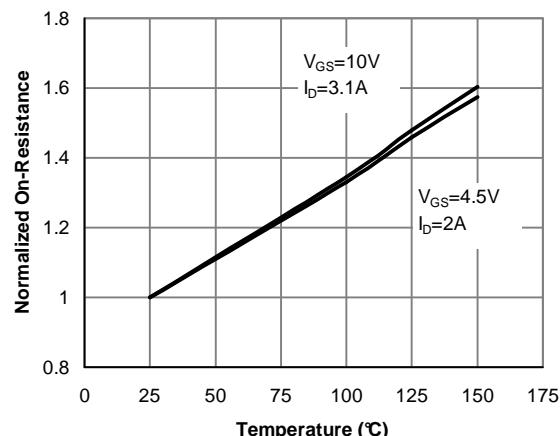


Figure 4: On-Resistance vs. Junction Temperature

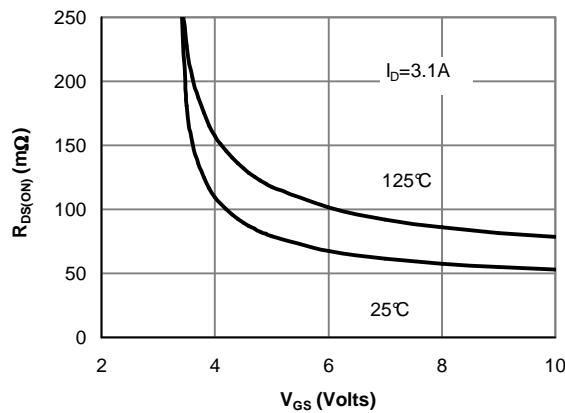


Figure 5: On-Resistance vs. Gate-Source Voltage

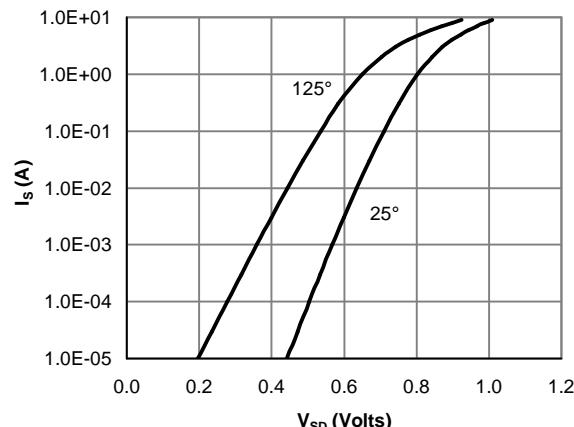
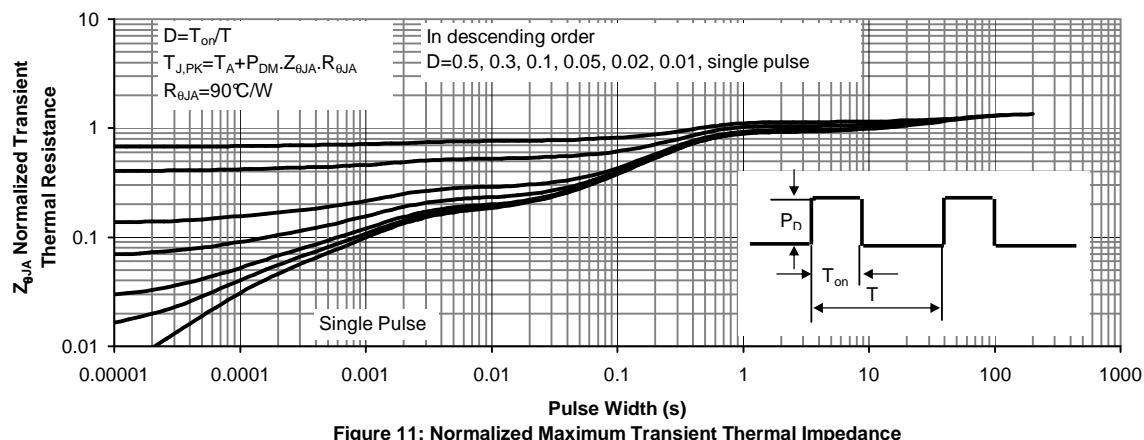
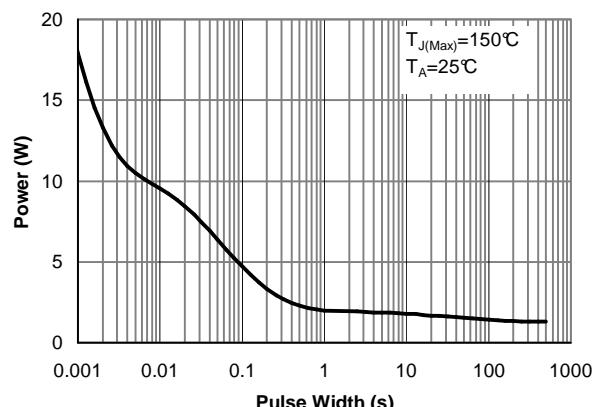
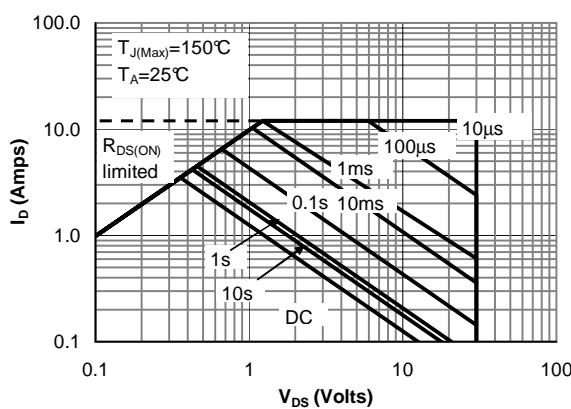
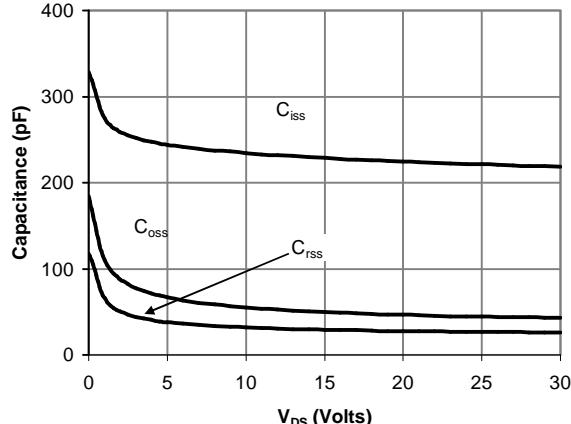
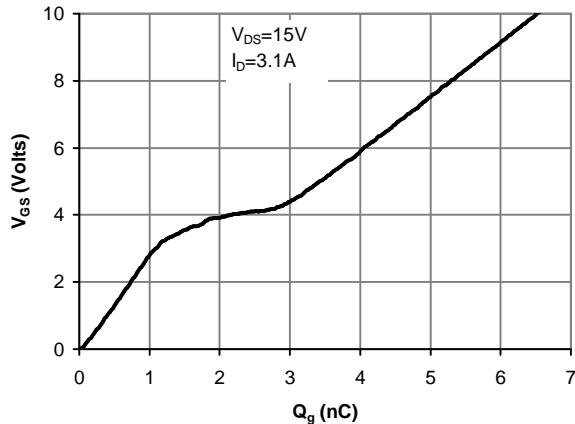


Figure 6: Body-Diode Characteristics

N-Channel Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

P-Channel Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|---|---------------------------------------|-------|----------|------------------|
| STATIC PARAMETERS | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $I_D=-250\mu\text{A}, V_{GS}=0\text{V}$ | -30 | | | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS}=-24\text{V}, V_{GS}=0\text{V}$ | $T_J=55^\circ\text{C}$ | -1 | -5 | μA |
| | | | | | | |
| I_{GSS} | Gate-Body leakage current | $V_{DS}=0\text{V}, V_{GS}=\pm20\text{V}$ | | | ±100 | nA |
| $V_{\text{GS(th)}}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}, I_D=-250\mu\text{A}$ | -1.2 | -1.9 | -2.5 | V |
| $I_{\text{D(ON)}}$ | On state drain current | $V_{GS}=-4.5\text{V}, V_{DS}=-5\text{V}$ | -5 | | | A |
| $R_{\text{DS(ON)}}$ | Static Drain-Source On-Resistance | $V_{GS}=-10\text{V}, I_D=-2.7\text{A}$ | $T_J=125^\circ\text{C}$ | 77 | 100 | $\text{m}\Omega$ |
| | | | | 110 | | |
| | | | $V_{GS}=-4.5\text{V}, I_D=-2\text{A}$ | 130 | 180 | $\text{m}\Omega$ |
| g_{FS} | Forward Transconductance | $V_{DS}=-5\text{V}, I_D=-2.7\text{A}$ | | 4.1 | | S |
| V_{SD} | Diode Forward Voltage | $I_S=-1\text{A}, V_{GS}=0\text{V}$ | | -0.81 | -1 | V |
| I_s | Maximum Body-Diode Continuous Current | | | | -2 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C_{iss} | Input Capacitance | $V_{GS}=0\text{V}, V_{DS}=-15\text{V}, f=1\text{MHz}$ | | 260 | 312 | pF |
| C_{oss} | Output Capacitance | | | 55 | | pF |
| C_{rss} | Reverse Transfer Capacitance | | | 44 | | pF |
| R_g | Gate resistance | $V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$ | | 4.3 | 5 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| $Q_g(10)$ | Total Gate Charge(10V) | $V_{GS}=-10\text{V}, V_{DS}=-15\text{V}, I_D=-2.7\text{A}$ | | 5.8 | 7 | nC |
| $Q_g(4.5)$ | Total Gate Charge(4.5V) | | | 3 | 4 | nC |
| Q_{gs} | Gate Source Charge | | | 0.78 | | nC |
| Q_{gd} | Gate Drain Charge | | | 1.6 | | nC |
| $t_{\text{D(on)}}$ | Turn-On DelayTime | $V_{GS}=-10\text{V}, V_{DS}=-15\text{V}, R_L=5.6\Omega, R_{\text{GEN}}=3\Omega$ | | 7 | | ns |
| t_r | Turn-On Rise Time | | | 6 | | ns |
| $t_{\text{D(off)}}$ | Turn-Off DelayTime | | | 15 | | ns |
| t_f | Turn-Off Fall Time | | | 7.5 | | ns |
| t_{rr} | Body Diode Reverse Recovery Time | $I_F=-2.7\text{A}, dI/dt=100\text{A}/\mu\text{s}$ | | 12.5 | 15 | ns |
| Q_{rr} | Body Diode Reverse Recovery Charge | $I_F=-2.7\text{A}, dI/dt=100\text{A}/\mu\text{s}$ | | 5.5 | | nC |

A: The value of R_{GJA} is measured with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$.

The value in any given application depends on the user's specific board design. The current rating is based on the $t \leq 10\text{s}$ thermal resistance rating.

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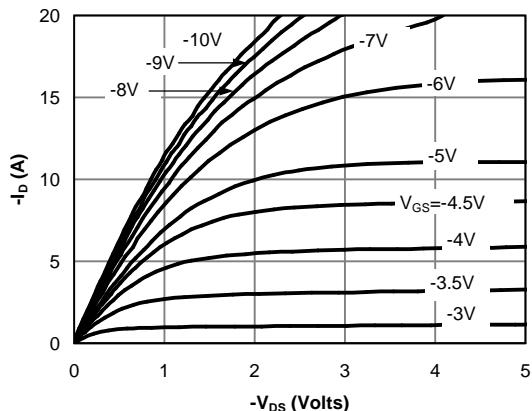
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: P-CHANNEL

Fig 1: On-Region Characteristics

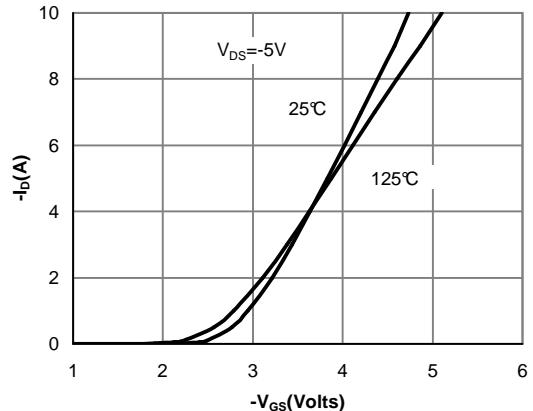


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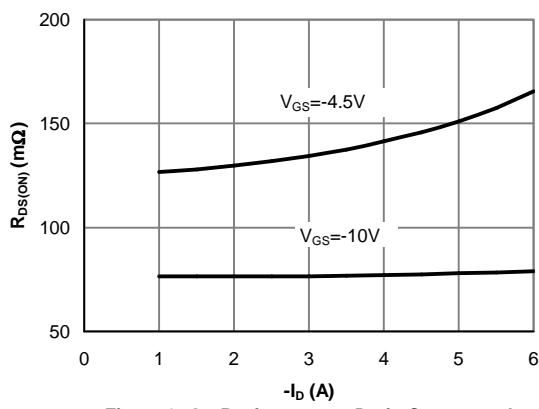


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

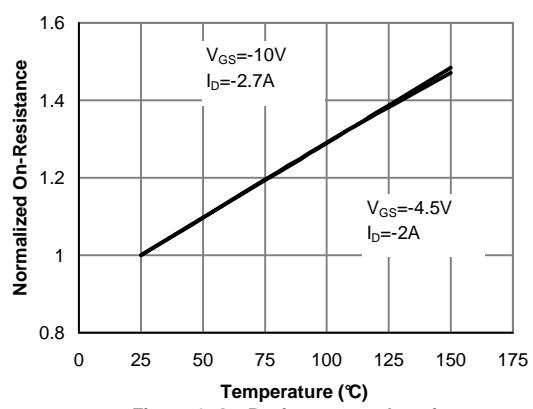


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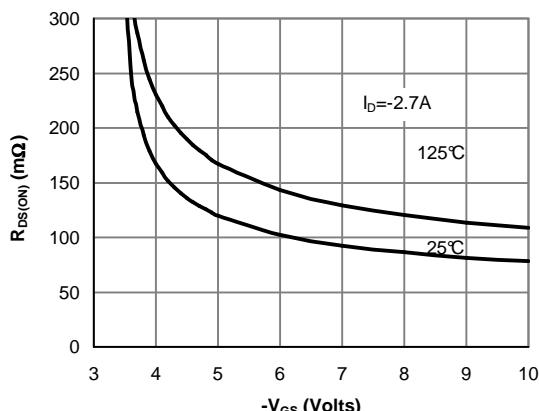


Figure 5: On-Resistance vs. Gate-Source Voltage

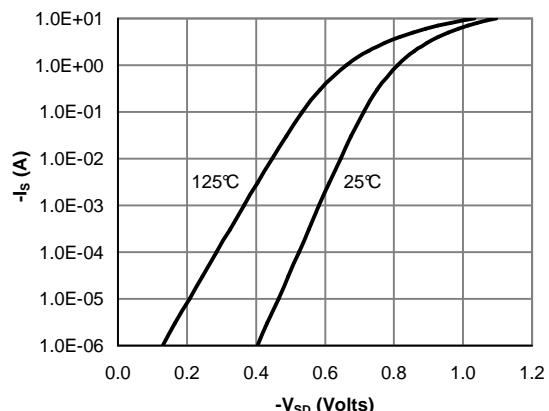


Figure 6: Body-Diode Characteristics

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